

<b>Notice of References Cited</b>	Application/Control No. 10/633,430	Applicant(s)/Patent Under Reexamination LEE, GUN WOO	
	Examiner Kurt Fernstrom	Art Unit 3714	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-D377,098	12-1996	Morimoto, Kenichi	D24/175
	B	US-3,182,746	05-1965	SCHAEFER II FREDERIC J	181/20
	C	US-3,259,204	07-1966	GERWICK JAMES A	181/20
	D	US-4,134,219	01-1979	Vilms, Juri	434/185
	E	US-D445,105	07-2001	Brinson, Beth W.	D14/187
	F	US-5,827,173	10-1998	Lindsay, Christine M.	600/28
	G	US-5,507,648	04-1996	Knopf, Jonathan D.	434/185
	H	US-3,867,770	02-1975	Davis, Michael S.	434/185
	I	US-6,632,095	10-2003	Ryan, Bruce P.	434/185
	J	US-4,579,124	04-1986	Jentges, Helen C.	600/538
	K	US-5,454,375	10-1995	Rothenberg, Martin	600/538
	L	US-3,155,189	11-1964	MACFARLANE CAROLYN H	181/20
	M	US-D189,450	12-1960	Cousino	D24/175

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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